Notice of References Cited

Application/Control No. 10/796,062	Reexamination	Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.		
Examiner	Art Unit			
Ja-Na Hines	1645	Page 1 of 1		

U.S. PATENT DOCUMENTS

*	*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
	D	US-			
	Ę	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
VI Q	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001-235477	08-2001	Japan	Nakanishi et al.	G01N 33/68
	0			·	·	
	Р					
	Q				:	,
L	R					
	s					
	Т			A		

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Bauer et al. 2000. Rapid Comm. in Mass Spectrometry. Vol. 14:924-929.
	V	Keough et al. 1999. PNAS. Vol. 96:7131-7136.
	w	Turecek. 2002. J. Mass Spectrometry. Vol. 37:1-14. Published online 21 December 2001.
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.